

Report On

Application for Grant of Equipment Authorization of the Oculus VR, LLC RE-A Remote (Simple Input Device)

FCC Part 15 Subpart C §15.247 (FHSS) IC RSS-247 Issue 1 May 2015 IC RSS-Gen Issue 4, November 2014

Report No. SD72112194-1215C

December 2015

FCC ID 2AGOZRE-A IC: 20849-REA

Report No. SD72112194-1215C



REPORT ON Radio Testing of the

Oculus VR, LLC

Remote (Simple Input Device)

TEST REPORT NUMBER SD72112194-1215C

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DATED December 16, 2015

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Revision History

SD72112194-1215C Oculus VR, LLC RE-A Remote (Simple Input Device)							
DATE	OLD REVISION	NEW REVISION	REASON	PAGES AFFECTED	APPROVED BY		
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SECTION 1

REPORT SUMMARY

Radio Testing of the Oculus VR, LLC Remote (Simple Input Device)



1.1 **INTRODUCTION**

The information contained in this report is intended to show verification of the Oculus VR, LLC RE-A Remote (Simple Input Device) to the requirements of FCC Part 15 Subpart C §15.247 and IC RSS-247 Issue 1 May 2015.

Objective To perform Radio Testing to determine the Equipment Under

Test's (EUT's) compliance with the Test Specification, for the

series of tests carried out.

Manufacturer Oculus VR, LLC

Model Number(s) RE-A

FCC ID Number 2AGOZRE-A

IC Number 20849-REA

Serial Number(s) N/A (Engineering Sample)

Number of Samples Tested 4 (Radiated samples only)

Test Specification/Issue/Date FCC Part 15 Subpart C §15.247 (October 1, 2014).

> IC RSS-247 Issue 1 May 2015 Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence-

Exempt Local Area Network (LE-LAN) Devices.

IC RSS-Gen Issue 4, November 2014 - General Requirements for Compliance of Radio Apparatus (Issue 4, November

2014).

Public Notice (DA 00-705 Released March 30, 2000) Filing and Measurement Guidelines for Frequency Hopping Spread

Spectrum Systems.

Start of Test October 08, 2015

Finish of Test October 12, 2015

Name of Engineer(s) Ferdinand Custodio

Related Document(s) setup and connection.txt

SD72112194-1215A Facebook Oculus HM-A FCC IC Part

15.247 RSS247 Test Report.docx

Supporting documents for EUT certification are separate

exhibits.



1.2 BRIEF SUMMARY OF RESULTS

A brief summary of the tests carried out in accordance with FCC Part 15 Subpart C §15.247 with cross-reference to the corresponding IC RSS standard is shown below.

Section	§15.247 Spec Clause	RSS	Test Description	Result	Comments /Base Standard
-	§15.207 (a)	RSS-Gen 8.8	Conducted Emissions	N/A	
2.1	§15.247(a)(1)	RSS-247 5.1 (2)	Carrier Frequency Separation	Compliant*	
2.2	§15.247(a)(1) (iii)	RSS-247 5.1 (4)	Number of Hopping Frequencies	Compliant*	
2.3	§15.247(a)(1) (iii)	RSS-247 5.1 (4)	Time of Occupancy (Dwell Time)	Compliant*	
2.4	§15.215(c)	RSS-247 5.1 (1)	20 dB Bandwidth	Compliant*	
2.5		RSS-Gen 6.6	99% Emission Bandwidth	Compliant*	
2.6	§15.247(b)(1)	RSS-247 5.4 (2)	Peak Output Power	Compliant*	
2.7	§15.247(d)	RSS-247 5.5	Band-edge Compliance of RF Conducted Emissions	Compliant*	
2.8	§15.247(d)	RSS-247 5.5	Spurious RF Conducted Emissions	Compliant	
2.9	§15.247(d)	RSS-Gen 8.9 and 8.10	Spurious Radiated Emissions	Compliant	
2.10	§15.247(d)	RSS-Gen 8.9 and 8.10	Radiated Immediate Restricted Bands	Compliant	

N/A

Compliant*

⁻ Not applicable. $\it EUT$ is a battery operated device.

⁻ Test results from SD72112194-1215A Facebook Oculus HM-A FCC IC Part 15.247 RSS247 Test Report.docx applies. All antenna conducted port verifications were performed on the Headset Master (HMD) that has the same RF chip; identical modulation scheme and identical radio transmit power as the EUT



1.3 **PRODUCT INFORMATION**

1.3.1 Technical Description

The Equipment Under Test (EUT) was an Oculus VR, LLC RE-A Remote (Simple Input Device) as shown in the photograph below. The EUT is part of a Virtual Reality Headset System comprising of the EUT, an Oculus Constellation Sensor and the Oculus Virtual Reality Headset.





Equipment Under Test



1.3.2 **EUT General Description**

EUT Description Remote (Simple Input Device) Model Name RE-A Model Number(s) RE-A Rated Voltage Coin Cell Battery (Lithium 3V CR2032) Mode Verified Proprietary 2.4GHz FHSS in the ISM Band Capability Proprietary 2.4GHz FHSS in the ISM Band Modulation **GFSK** Production Primary Unit (EUT) Pre-Production **Engineering** Antenna Type Multilayer Ceramic Antenna Antenna Manufacturer **PSA Walsin Technology Corporation** Antenna Model Number RFANT3216120A5T Series **Antenna Dimensions** 3.2mm x 1.6mm x 1.2mm Antenna Gain 2.12dBi

1.3.3 Maximum Conducted Output Power

Mode	Frequency Range (MHz)	AverageOutput Power (dBm))	Peak Output Power (dBm)	Peak Output Power (mW)
FHSS	2404-2478	0.22	2.57	1.81



1.4 **EUT TEST CONFIGURATION**

1.4.1 Test Configuration Description

Test Configuration	Description
А	Antenna Conducted Port Single Carrier Test Mode. Actual verifications were performed on the Headset Master (HMD) that has the same RF chip; identical modulation scheme and identical radio transmit power as the EUT (Headset Master has a temporary antenna connector for conducted RF testing). The term "EUT" referred in this test report therefore applies to both the Headset Master (Conducted) and the Tracker (Radiated). Manufacturer provided a Command Prompt window wherein a command could be issued forcing the EUT to single carrier test mode.
В	Radiated Test Mode. Manufacturer provided separate single carrier transmitting samples for Low, Mid and High channels. For hopping requirement, a normal sample was also provided which defaults to hopping mode when powered up.

1.4.2 **EUT Exercise Software**

Command Prompt window on the host PC (support laptop) to program as per Test Configuration (Section 1.4.1).

1.4.3 Support Equipment and I/O cables

Manufacturer	Equipment/Cable	Description
Apple Inc.	Support laptop	Model MacBookPro 11.3 S/N: C02LX29CFR1M

1.4.4 Worst Case Configuration

1.4.5 Worst Case Configuration

The EUT has only one modulation scheme. Being a mobile device, the EUT was verified on all axes. Only the worst axis ("X") presented in this test report for radiated measurements. Worst case Channel based from power measurements is Low channel.

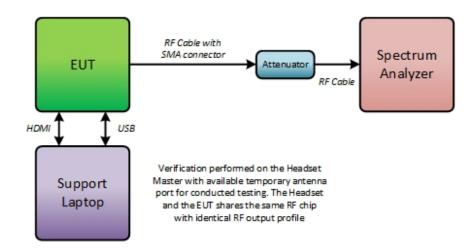








1.4.6 Simplified Test Configuration Diagram (Antenna conducted port otherwise stand-alone for Radiated)





1.5 **DEVIATIONS FROM THE STANDARD**

No deviations from the applicable test standards or test plan were made during testing.

1.6 MODIFICATION RECORD

Description of Modification	Modification Fitted By	Date Modification Fitted
Serial Number N/A		
N/A		

The table above details modifications made to the EUT during the test programme. The modifications incorporated during each test (if relevant) are recorded on the appropriate test pages.

1.7 **TEST METHODOLOGY**

All measurements contained in this report were conducted with ANSI C63.4-2014, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

For conducted and radiated emissions the equipment under test (EUT) was configured to measure its highest possible emission level. This level was based on the maximized cable configuration from exploratory testing per ANSI C63.4-2014. The test modes were adapted according to the Operating Instructions provided by the manufacturer/client.

1.8 TEST FACILITY LOCATION

1.8.1 TÜV SÜD America Inc. (Mira Mesa)

10040 Mesa Rim Road, San Diego, CA 92121-2912 (32.901268,-117.177681). Phone: 858 678 1400 FAX: 858-546 0364

1.8.2 TÜV SÜD America Inc. (Rancho Bernardo)

Sony Electronics Inc., Building #8 16530 Via Esprillo, San Diego, CA 92127-1708 (33.018644,-117.092409). Phone: 858 942 5542 FAX: 858-546 0364

1.9 TEST FACILITY REGISTRATION

1.9.1 **FCC – Registration No.: US1146**

TUV SUD America Inc. (San Diego), is an accredited test facility with the site description report on file and has met all the requirements specified in §2.948 of the FCC rules. The acceptance letter from the FCC is maintained in our files and the Registration is US1146.

FCC ID 2AGOZRE-A IC: 20849-REA Report No. SD72112194-1215C



1.9.2 Industry Canada (IC) Registration No.: 3067A

The 10m Semi-anechoic chamber of TUV SUD America Inc. (San Diego) has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No. 3067A.

FCC ID 2AGOZRE-A IC: 20849-REA Report No. SD72112194-1215C



SECTION 2

TEST DETAILS

Radio Testing of the Oculus VR, LLC Remote (Simple Input Device)



2.1 CARRIER FREQUENCY SEPARATION

2.1.1 Specification Reference

Part 15 Subpart C §15.247(a)(1) and RSS-247 5.1 (2)

2.1.2 Standard Applicable

(1) Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400–2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW. The system shall hop to channel frequencies that are selected at the system hopping rate from a pseudo randomly ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

2.1.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.1.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.1.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.1.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature 24.8 °C Relative Humidity 57.1 % ATM Pressure 99.1 kPa

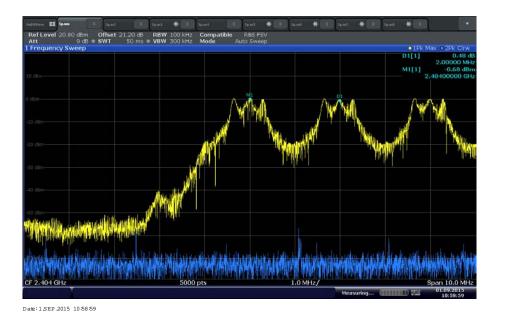
2.1.7 Additional Observations

- Hopping function enabled.
- Span is wide enough to capture the peaks of two adjacent channels.
- RBW is 1% of the span.
- VBW is 3x RBW
- Sweep is auto



- Detector is peak.
- Trace is max hold.
- An offset of 21.2dB was added to compensate for the external attenuator and cable used.
- Marker-delta function is used between the peaks of the adjacent channels.
- Limit used is >490 kHz (2/3 of worst case 20dB BW).

2.1.8 Test Results



Observed carrier frequency separation between Channel 4 and Channel 6 = 2 MHz (**Complies**. Greater than 490 kHz, this is 2/3 of 0.7352 MHz 20 dB BW)



2.2 NUMBER OF HOPPING FREQUENCIES

2.2.1 Specification Reference

Part 15 Subpart C §15.247(a)(1)(iii) and RSS-247 5.1 (4)

2.2.2 Standard Applicable

(iii) Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

2.2.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.2.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.2.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.2.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

 $\begin{array}{ll} \mbox{Ambient Temperature} & 24.8\,^{\circ}\mbox{C} \\ \mbox{Relative Humidity} & 57.1\,\% \\ \mbox{ATM Pressure} & 99.1\,\mbox{kPa} \end{array}$

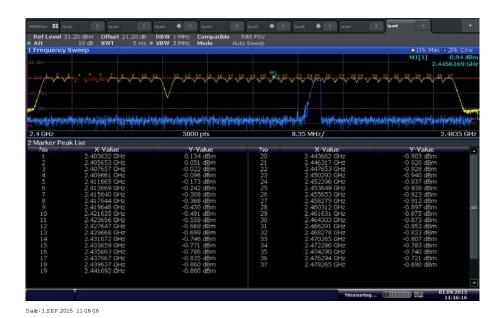
2.2.7 Additional Observations

- Hopping function enabled.
- Span was set to the entire Frequency Band.
- RBW is >1% of the span.
- VBW is 3x RBW
- Sweep is auto
- Trace was set to Max Hold.
- Marker Peak List function of the spectrum analyzer was used for this test.

2.2.8 Test Results

Observed Number of Hopping Frequencies is = 37 (Complies)





2.4 GHz Frequency Band showing 37 channels where the EUT hops



2.3 TIME OF OCCUPANCY (DWELL TIME)

2.3.1 Specification Reference

Part 15 Subpart C §15.247(a)(1)(iii) and RSS-247 5.1 (4)

2.3.2 Standard Applicable

(iii) Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

2.3.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.3.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.3.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.3.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature 24.8 °C Relative Humidity 57.1 % ATM Pressure 99.1 kPa

2.3.7 Additional Observations

- Hopping function enabled.
- Span = zero span, centered on a hopping channel.
- RBW is 1MHz.
- VBW is 3x RBW
- Detector is peak.
- A single pulse is first measured. This measurement is then used to compute the average time of occupancy in the required period (no. of channels x 0.4 second).
- Marker Peak List function of the spectrum analyzer was used to determine the number of pulses within 3.16 seconds.
- Threshold set to -10 dBm in order to capture actual transmission within the channel being investigated (adjacent channel transmissions are rejected).



2.3.8 Test Results

Modulation	Measured time of occupancy	Requirement
GFSK	4.28 ms	<400 ms

2.3.9 Sample Computation

Width of single pulse = 0.000214 second
Observed occurrence = 20 pulses/1.48 seconds
Required period = 37 channels x 0.4 second

= 14.8 seconds

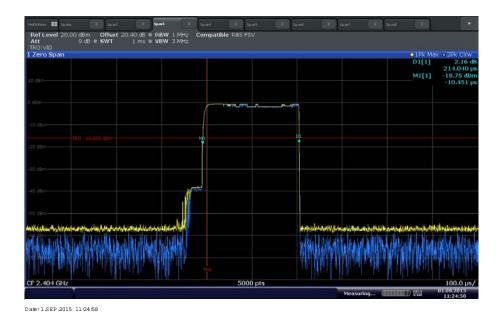
Average time of occupancy = Pulse width x #pulses in 1.48 seconds x 10

= 0.000214 second x 20 x 10

= 0.0428 second

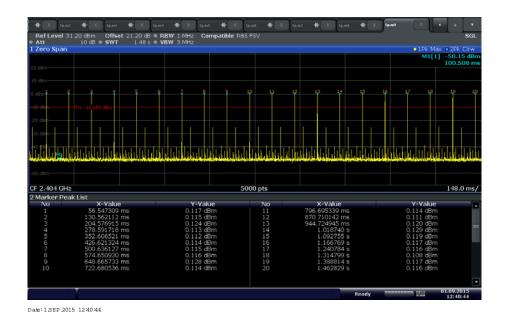
Compliance = Complies. 0.0428 second < 0.4 second

2.3.10 Test Results Plots



GFSK width of single pulse (0.214 ms)





20 pulses/1.48 seconds



2.4 **20 dB BANDWIDTH**

2.4.1 Specification Reference

Part 15 Subpart C §15.215(c) and RSS-247 5.1 (1)

2.4.2 Standard Applicable

(c) Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§15.217 through 15.257 and in Subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated. The requirement to contain the designated bandwidth of the emission within the specified frequency band includes the effects from frequency sweeping, frequency hopping and other modulation techniques that may be employed as well as the frequency stability of the transmitter over expected variations in temperature and supply voltage. If a frequency stability is not specified in the regulations, it is recommended that the fundamental emission be kept within at least the central 80% of the permitted band in order to minimize the possibility of out-of-band operation.

2.4.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.4.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.4.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.4.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

 $\begin{array}{lll} \mbox{Ambient Temperature} & 24.8 \ ^{\circ}\mbox{C} \\ \mbox{Relative Humidity} & 57.1 \ \% \\ \mbox{ATM Pressure} & 99.1 \ \text{kPa} \end{array}$

2.4.7 Additional Observations

- This is a conducted test.
- An offset of 21.2dB was added to compensate for the external attenuator and cable used.
- Span is approximately 2 to 3 times the expected 20dB bandwidth.
- RBW is ≥ 1% of the expected 20dB bandwidth while VBW is ≥ RBW.
- Sweep is auto.
- Detector is peak.
- Max hold function activated.
- "n dB down" marker function (20dB) of the spectrum analyzer was used for this test.



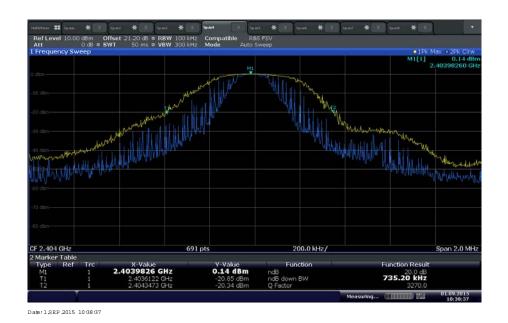
2.4.8 Test Results

Modulation	Channel	Frequency (MHz)	Measured 20dB Bandwidth (MHz)
	4	2404	0.7352
GFSK	40	2440	0.7120
	78	2478	0.7265

Using worst case 20 dB BW:

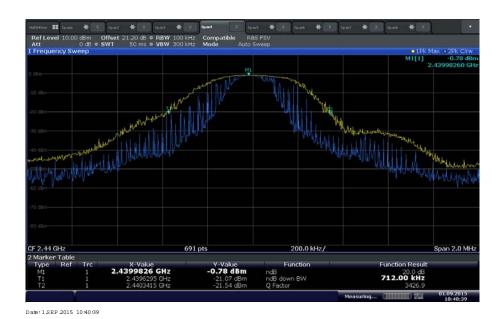
2404 MHz - (0.7352/2) = 2403.6324 MHz (within the frequency band - **Compliant**) 2478 MHz + (0.7352/2) = 2478.3675 MHz (within the frequency band - **Compliant**)

2.4.9 Test Results Plots

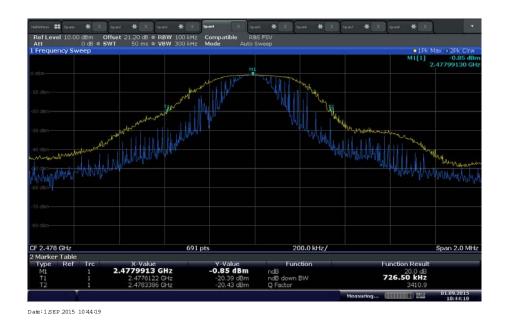


Low Channel (2404 MHz)





Mid Channel (2440 MHz)



High Channel (2478 MHz)



2.5 99% EMISSION BANDWIDTH

2.5.1 Specification Reference

RSS-Gen Clause 6.6

2.5.2 Standard Applicable

The emission bandwidth (x dB) is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated x dB below the maximum in-band spectral density of the modulated signal. Spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth in the range of 1% to 5% of the anticipated emission bandwidth, and a video bandwidth at least 3x the resolution bandwidth.

When the occupied bandwidth limit is not stated in the applicable RSS or reference measurement method, the transmitted signal bandwidth shall be reported as the 99% emission bandwidth, as calculated or measured.

- The transmitter shall be operated at its maximum carrier power measured under normal test conditions.
- The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts.
- The resolution bandwidth (RBW) shall be in the range of 1% to 5% of the occupied bandwidth (OBW) and video bandwidth (VBW) shall be approximately 3x RBW.

Note: Video averaging is not permitted.

A peak, or peak hold, may be used in place of the sampling detector as this may produce a wider bandwidth than the actual bandwidth (worst-case measurement). Use of a peak hold may be necessary to determine the occupied bandwidth if the device is not transmitting continuously.

The trace data points are recovered and are directly summed in linear power level terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5% of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points (starting at the highest frequency, at the right side of the span, and going down in frequency). This frequency is then recorded.

The difference between the two recorded frequencies is the 99% occupied bandwidth.

2.5.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.5.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.5.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.5.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.



 $\begin{array}{ll} \mbox{Ambient Temperature} & 24.8\ ^{\circ}\mbox{C} \\ \mbox{Relative Humidity} & 57.1\ \% \\ \mbox{ATM Pressure} & 99.1\ \mbox{kPa} \end{array}$

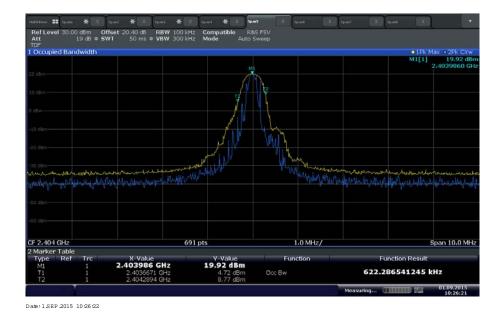
2.5.7 Additional Observations

- This is a conducted test.
- A TDF factor was used to compensate for the external attenuator and cable used within the frequency band.
- Span is wide enough to capture the channel transmission.
- RBW is 1% of the span.
- VBW is 3X RBW.
- Sweep is auto.
- Detector is peak.
- The % Power Bandwidth setting in the spectrum analyzer was set to 99% (default).
- The OBW power measurement function of the spectrum analyzer was used for this test.

2.5.8 Test Results (For reporting purposes only)

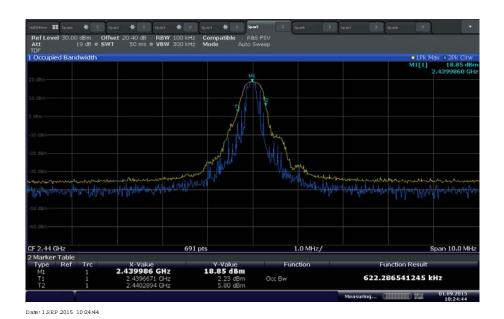
Modulation	Channel	Frequency (MHz)	Measured 20dB Bandwidth (MHz)
	4	2404	0.622
GFSK	40	2440	0.622
	78	2478	0.637

2.5.9 Test Results Plots

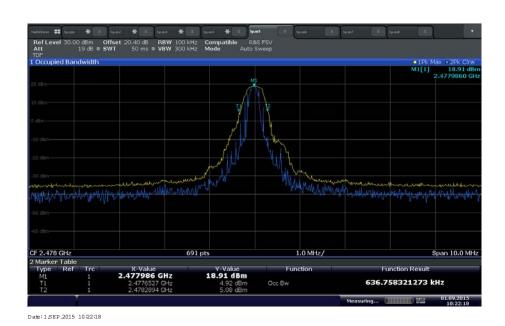


Low Channel (2404 MHz)





Mid Channel (2440 MHz)



High Channel (2478 MHz)



2.6 **PEAK OUTPUT POWER**

2.6.1 Specification Reference

Part 15 Subpart C §15.247(b)(1) and RSS-247 5.4 (2)

2.6.2 Standard Applicable

(1) For frequency hopping systems operating in the 2400–2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725–5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400–2483.5 MHz band: 0.125 watts.

For FHSs operating in the band 2400-2483.5 MHz, the maximum peak conducted output power shall not exceed 1.0 W and the e.i.r.p. shall not exceed 4 W if the hopset uses 75 or more hopping channels; the maximum peak conducted output power shall not exceed 0.125 W and the e.i.r.p. shall not exceed 0.5 W if the hopset uses less than 75 hopping channels (see Section 5.4(5) for exceptions).

2.6.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.6.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.6.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.6.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature 24.8 °C Relative Humidity 57.1 % ATM Pressure 99.1 kPa

2.6.7 Additional Observations

- This is a conducted test using a Peak Power Meter.
- An offset of 21.2dB was added to compensate for the external attenuator and cable used.
- EUT was verified while in single carrier test mode.



2.6.8 Test Results (Conducted)

Modulation	Channel	Frequency (MHz)	Measured Average Output Power (dBm)	Measured Peak Output Power (dBm)	Measured Peak Output Power (mW)	Limit (mW)
	4	2404	0.22	2.57	1.81	125.0
GFSK	40	2440	-0.81	2.27	1.69	125.0
	78	2478	-0.64	2.20	1.66	125.0

2.6.9 Test Results (*De Facto* EIRP Limit)

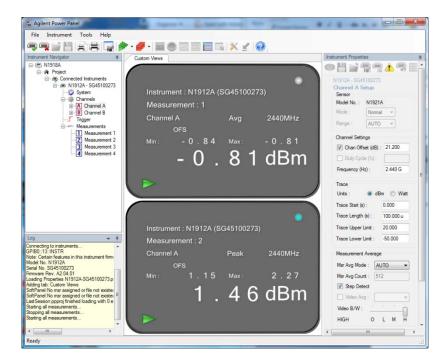
Modulation	Channel	Frequency (MHz)	Measured Peak Output Power (dBm))	Antenna Gain (dBi)	Calculated Peak Output Power EIRP (dBm))	Limit (dBm))
GFSK	4	2404	2.57	2.12	4.69	27

2.6.10 Test Display

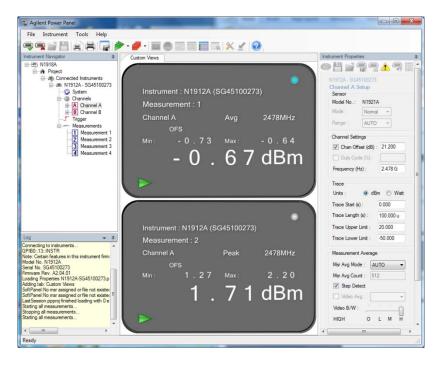


Low channel (Channel 4 2404 MHz)





Mid channel (Channel 40 2440 MHz)



High channel (Channel 78 2478 MHz)



2.7 BAND-EDGE COMPLIANCE OF RF CONDUCTED EMISSIONS

2.7.1 Specification Reference

Part 15 Subpart C §15.247(d) and RSS-247 5.5

2.7.2 Standard Applicable

(d) In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

2.7.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.7.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.7.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.7.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature 24.8 °C Relative Humidity 57.1 % ATM Pressure 99.1 kPa

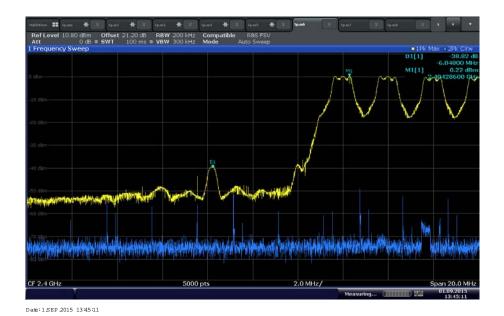
2.7.7 Additional Observations

- This is a conducted test.
- An offset of 21.2dB was added to compensate for the external attenuator and cable used.
- Span is wide enough to capture the peak level of the emission operating on the channel closest to the band edge.
- RBW is \geq 1% of the span, VBW is \geq RBW.
- Sweep is auto, detector is peak, trace is max hold.
- Trace allowed to stabilize. Marker-delta function used to verify compliance.

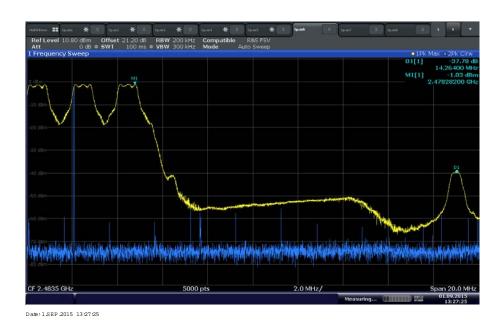


- Limit is 20dBc.
- Both Hopping and Non-Hopping mode verified.

2.7.8 Test Results

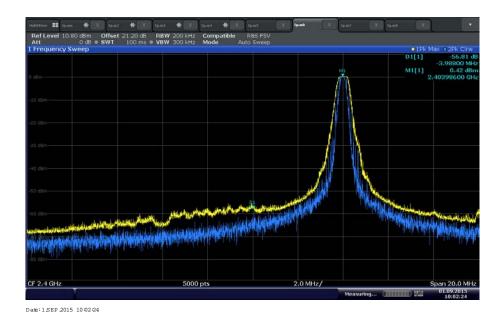


Hopping lower band edge

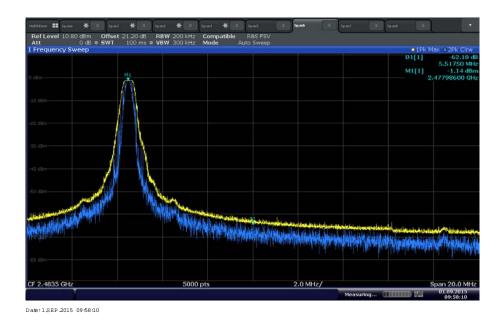


Hopping upper band edge





Non-hopping lower band edge



Non-hopping upper band edge



2.8 SPURIOUS RF CONDUCTED EMISSIONS

2.8.1 Specification Reference

Part 15 Subpart C §15.247(d) and RSS-247 5.5

2.8.2 Standard Applicable

(d) In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

2.8.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration A

2.8.4 Date of Test/Initial of test personnel who performed the test

October 08, 2015/FSC

2.8.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.8.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility.

Ambient Temperature 24.8 °C Relative Humidity 57.1 % ATM Pressure 99.1 kPa

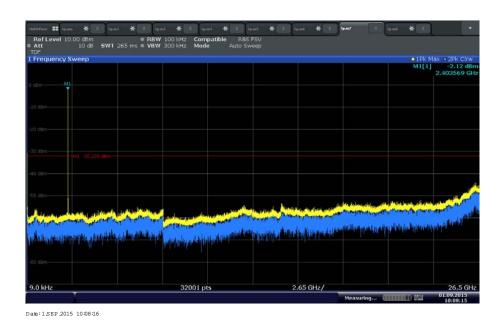
2.8.7 Additional Observations

- This is a conducted test.
- A TDF factor was used to compensate for the external attenuator and cable used within the frequency band.
- Span is from 9 kHz up to 26.5GHz (to cover 10th harmonic of the High Channel).
- Sweep point setting of the spectrum analyzer is set to maximum (32001).
- RBW is 100 kHz, VBW is ≥ RBW.
- Sweep is auto, detector is peak.

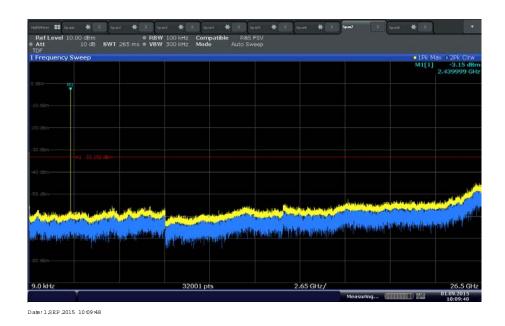


- Trace is max hold.
- Trace allowed to stabilize. Maximum spurious emission compared to limit.
- Limit is 20dBc (30dBc presented, worst case).

2.8.8 Test Results Plots

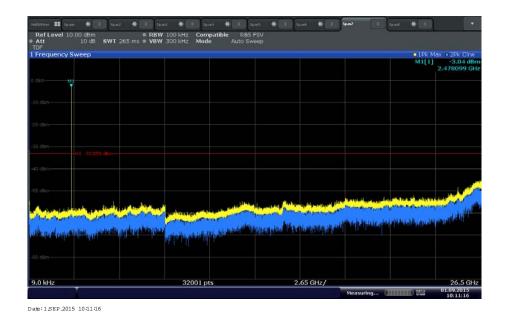


Low Channel (2404 MHz)



Mid Channel (2440 MHz)





High Channel (2478 MHz)

Report No. SD72112194-1215C



2.9 SPURIOUS RADIATED EMISSIONS

2.9.1 Specification Reference

Part 15 Subpart C §15.247(d) and RSS-Gen 8.9 / 8.10

2.9.2 Standard Applicable

(d) In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

2.9.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration B

2.9.4 Date of Test/Initial of test personnel who performed the test

October 12, 2015/FSC

2.9.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.9.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility

Ambient Temperature 24.6 °C Relative Humidity 48.2 % ATM Pressure 98.7 kPa

2.9.7 Additional Observations

- This is a radiated test. The spectrum was searched from 30MHz to the 10th harmonic.
- There are no emissions found that do not comply to the restricted bands defined in FCC Part 15 Subpart C, 15.205 or Part 15.247(d).
- Only noise floor measurements observed above 18GHz.
- Measurement was done using EMC32 automated software. Reported level is the actual level with all the correction factors factored in. Correction Factor column is for informational purposes only. See Section 2.9.8 for sample computation.



2.9.8 Sample Computation (Radiated Emission)

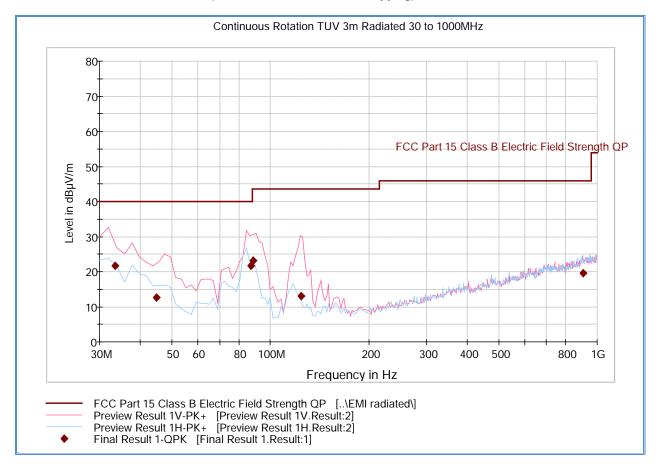
Measuring equipment raw measur		24.4	
	Asset# 1066 (cable)	0.3	
	0.3		
Correction Factor (dB)	Asset# 1016 (preamplifier)	-30.7	-12.6
	Asset# 1175(cable)	0.3	
	17.2		
Reported QuasiPeak Final Measur		11.8	

2.9.9 **Test Results**

See attached plots.



2.9.10 Test Results Below 1GHz (Worst Case Channel – Non-hopping)



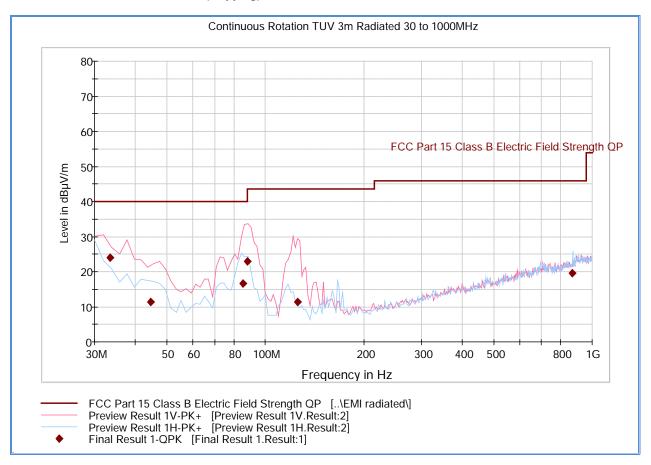
Quasi Peak Data

Frequency (MHz)	QuasiPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
33.400000	21.6	1000.0	120.000	141.0	V	338.0	-13.3	18.4	40.0
44.734990	12.6	1000.0	120.000	100.0	V	251.0	-18.5	27.4	40.0
87.348858	21.8	1000.0	120.000	100.0	V	10.0	-21.3	18.2	40.0
88.732745	23.2	1000.0	120.000	100.0	V	-15.0	-21.0	20.3	43.5
123.906613	13.0	1000.0	120.000	200.0	V	349.0	-20.8	30.5	43.5
904.125611	19.6	1000.0	120.000	139.0	V	100.0	1.2	26.4	46.0

Test Notes: Only worst case channel presented for spurious emissions below 1GHz.



2.9.11 Test Results Below 1GHz (Hopping)



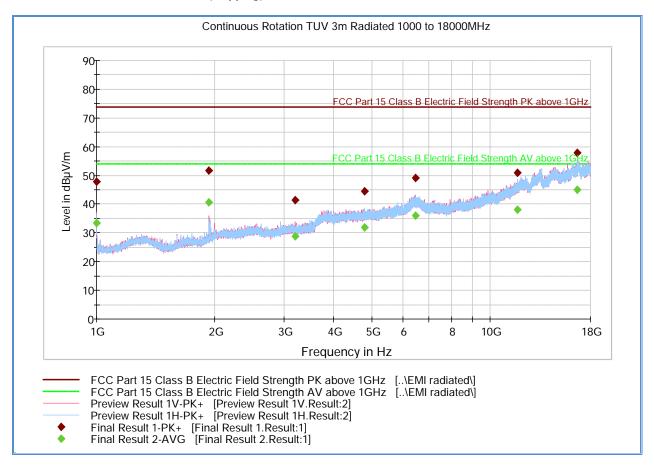
Quasi Peak Data

Frequency (MHz)	QuasiPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
33.480000	24.0	1000.0	120.000	106.0	V	318.0	-13.3	16.0	40.0
44.574990	11.3	1000.0	120.000	100.0	V	258.0	-18.4	28.7	40.0
85.388858	16.7	1000.0	120.000	200.0	V	11.0	-21.5	23.3	40.0
88.052745	23.0	1000.0	120.000	100.0	V	7.0	-21.2	20.5	43.5
125.290501	11.4	1000.0	120.000	200.0	V	344.0	-20.9	32.1	43.5
870.783407	19.6	1000.0	120.000	200.0	Н	309.0	-0.3	26.4	46.0

Test Notes:



2.9.12 Test Results Above 1GHz (Hopping)



Peak Data

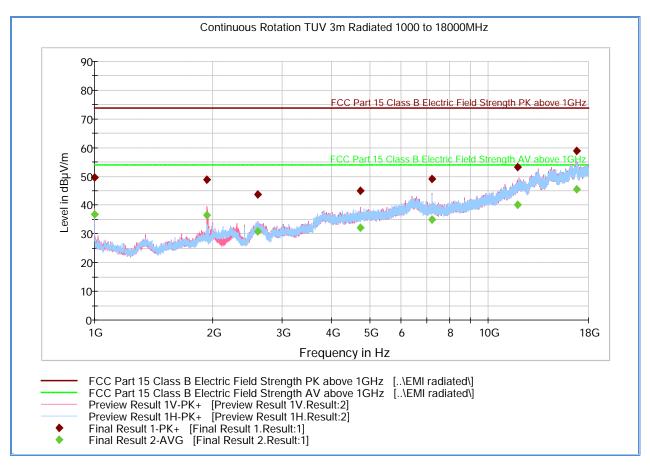
Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
1000.400000	47.9	1000.0	1000.000	200.5	V	20.0	-7.2	26.0	73.9
1932.400000	51.7	1000.0	1000.000	274.3	V	143.0	-2.3	22.2	73.9
3191.666667	41.5	1000.0	1000.000	276.3	٧	257.0	1.4	32.4	73.9
4801.633333	44.5	1000.0	1000.000	154.7	Н	-9.0	5.7	29.4	73.9
6469.666667	49.0	1000.0	1000.000	103.7	V	150.0	11.5	24.9	73.9
11711.533333	51.0	1000.0	1000.000	140.7	Н	273.0	16.5	22.9	73.9
16682.866667	58.0	1000.0	1000.000	195.5	Н	-1.0	24.2	15.9	73.9

Average Data

age Data	0										
Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)		
1000.400000	33.3	1000.0	1000.000	200.5	V	20.0	-7.2	20.6	53.9		
1932.400000	40.6	1000.0	1000.000	274.3	V	143.0	-2.3	13.3	53.9		
3191.666667	28.8	1000.0	1000.000	276.3	V	257.0	1.4	25.1	53.9		
4801.633333	31.9	1000.0	1000.000	154.7	Н	-9.0	5.7	22.0	53.9		
6469.666667	35.9	1000.0	1000.000	103.7	V	150.0	11.5	18.0	53.9		
11711.533333	38.0	1000.0	1000.000	140.7	Н	273.0	16.5	15.9	53.9		
16682.866667	45.0	1000.0	1000.000	195.5	Н	-1.0	24.2	8.9	53.9		



2.9.13 Test Results Above 1GHz Low Channel



Peak Data

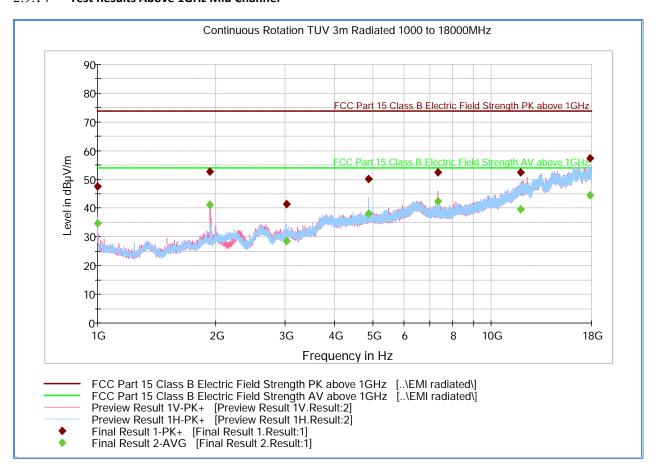
											
Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)		
1000.000000	49.7	1000.0	1000.000	180.6	V	150.0	-7.2	24.2	73.9		
1932.366667	48.9	1000.0	1000.000	224.4	V	288.0	-2.3	25.0	73.9		
2598.533333	43.6	1000.0	1000.000	174.6	Н	26.0	0.1	30.3	73.9		
4732.433333	45.0	1000.0	1000.000	148.7	V	58.0	5.8	28.9	73.9		
7213.133333	49.2	1000.0	1000.000	136.7	٧	163.0	10.0	24.7	73.9		
11897.533333	53.3	1000.0	1000.000	286.2	V	279.0	17.7	20.6	73.9		

Average Data

r	age Data									
	Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
	1000.000000	36.7	1000.0	1000.000	180.6	V	150.0	-7.2	17.2	53.9
	1932.366667	36.4	1000.0	1000.000	224.4	V	288.0	-2.3	17.5	53.9
	2598.533333	30.7	1000.0	1000.000	174.6	Н	26.0	0.1	23.2	53.9
	4732.433333	32.1	1000.0	1000.000	148.7	V	58.0	5.8	21.8	53.9
	7213.133333	35.1	1000.0	1000.000	136.7	V	163.0	10.0	18.8	53.9
	11897.533333	40.0	1000.0	1000.000	286.2	V	279.0	17.7	13.9	53.9



2.9.14 Test Results Above 1GHz Mid Channel



Peak Data

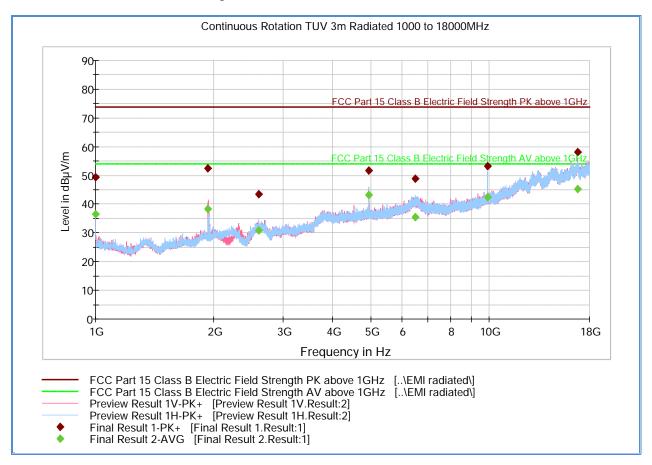
Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
1000.000000	47.7	1000.0	1000.000	244.4	V	-3.0	-7.2	26.2	73.9
1932.566667	52.6	1000.0	1000.000	232.4	V	183.0	-2.3	21.3	73.9
3025.666667	41.4	1000.0	1000.000	169.6	Н	151.0	1.2	32.5	73.9
4879.366667	50.2	1000.0	1000.000	123.7	Н	33.0	6.1	23.7	73.9
7319.433333	52.4	1000.0	1000.000	198.5	V	122.0	9.8	21.5	73.9
11907.433333	52.4	1000.0	1000.000	168.6	V	48.0	17.8	21.5	73.9
17833.366667	57.2	1000.0	1000.000	179.5	Н	58.0	24.1	16.7	73.9

Average Data

age Data	90 Pata										
Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)		
1000.000000	34.8	1000.0	1000.000	244.4	V	-3.0	-7.2	19.1	53.9		
1932.566667	41.1	1000.0	1000.000	232.4	V	183.0	-2.3	12.8	53.9		
3025.666667	28.4	1000.0	1000.000	169.6	Н	151.0	1.2	25.5	53.9		
4879.366667	38.0	1000.0	1000.000	123.7	Н	33.0	6.1	15.9	53.9		
7319.433333	42.3	1000.0	1000.000	198.5	V	122.0	9.8	11.6	53.9		
11907.433333	39.7	1000.0	1000.000	168.6	V	48.0	17.8	14.2	53.9		
17833.366667	44.5	1000.0	1000.000	179.5	Н	58.0	24.1	9.4	53.9		



2.9.15 Test Results Above 1GHz High Channel



Peak Data

Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
1000.000000	49.3	1000.0	1000.000	186.5	V	164.0	-7.2	24.6	73.9
1932.533333	52.5	1000.0	1000.000	151.6	V	120.0	-2.3	21.4	73.9
2598.533333	43.5	1000.0	1000.000	234.4	Н	23.0	0.1	30.4	73.9
4955.700000	51.7	1000.0	1000.000	120.7	Н	299.0	6.5	22.2	73.9
6482.700000	48.8	1000.0	1000.000	300.6	Н	3.0	11.5	25.1	73.9
9912.366667	53.3	1000.0	1000.000	197.5	Н	-20.0	12.9	20.6	73.9
16813.433333	58.1	1000.0	1000.000	124.7	٧	279.0	24.6	15.8	73.9

Average Data

luge Dutu	0										
Freque (MHz		Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)	
1000.00	0000	36.4	1000.0	1000.000	186.5	V	164.0	-7.2	17.5	53.9	
1932.53	3333	38.4	1000.0	1000.000	151.6	V	120.0	-2.3	15.5	53.9	
2598.53	3333	30.7	1000.0	1000.000	234.4	Н	23.0	0.1	23.2	53.9	
4955.70	0000	43.3	1000.0	1000.000	120.7	Н	299.0	6.5	10.6	53.9	
6482.70	0000	35.6	1000.0	1000.000	300.6	Н	3.0	11.5	18.3	53.9	
9912.36	6667	42.5	1000.0	1000.000	197.5	Н	-20.0	12.9	11.4	53.9	
16813.43	3333	45.2	1000.0	1000.000	124.7	V	279.0	24.6	8.7	53.9	

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2.10 RADIATED IMMEDIATE RESTRICTED BANDS

2.10.1 Specification Reference

Part 15 Subpart C §15.247(d) and RSS-Gen 8.9 / 8.10

2.10.2 Standard Applicable

(d) In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

2.10.3 Equipment Under Test and Modification State

Serial No: N/A /Test Configuration B

2.10.4 Date of Test/Initial of test personnel who performed the test

October 12, 2015/FSC

2.10.5 Test Equipment Used

The major items of test equipment used for the above tests are identified in Section 3.1.

2.10.6 Environmental Conditions

Test performed at TÜV SÜD America Inc. Rancho Bernardo facility

Ambient Temperature 24.6 °C Relative Humidity 48.2 % ATM Pressure 98.7 kPa

2.10.7 Additional Observations

- This is a radiated test. The spectrum was searched from 2310MHz to 2390MHz for lower immediate restricted band and 2483.5MHz to 2500MHz for the upper immediate restricted band.
- There are no emissions found that do not comply with the restricted bands defined in FCC Part 15 Subpart C, 15.205.
- Both Non-hopping and Hopping modes presented.



• Measurement was done using EMC32 automated software. Reported level is the actual level with all the correction factors factored in. Correction Factor column is for informational purposes only. See Section 2.10.8 for sample computation.

2.10.8 Sample Computation (Radiated Emission)

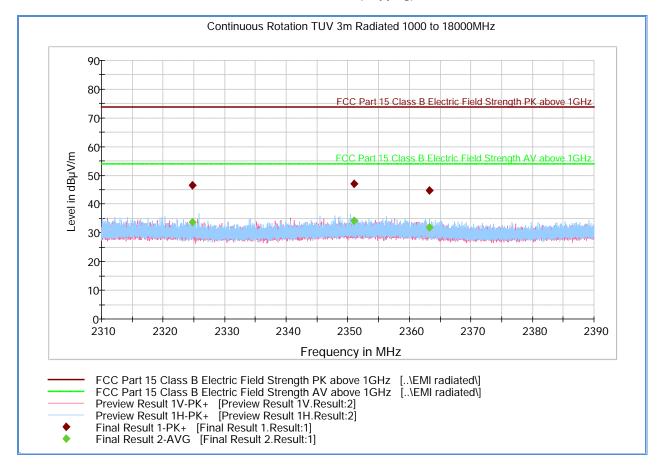
Measuring equipment raw measur	ement (dbμV) @ 2400 MHz		53.9
Correction Factor (dB)	Asset# 8628(preamplifier)	-36.5	-0.4
	32.7		
Reported Max Peak Final Measure		53.5	

2.10.9 Test Results

See attached plots.



2.10.10 Test Results Restricted Band 2310MHz to 2390MHz (Hopping)



Peak Data

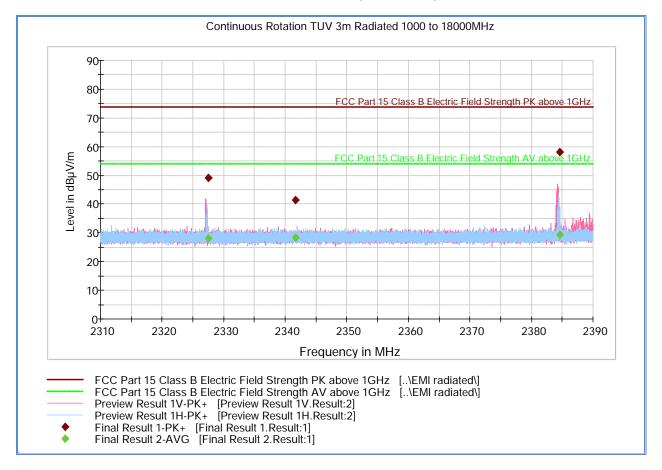
Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
2324.808000	46.6	1000.0	1000.000	102.8	Н	134.0	-0.6	27.3	73.9
2351.074667	47.0	1000.0	1000.000	103.7	Н	141.0	-0.7	26.9	73.9
2363.296000	44.7	1000.0	1000.000	101.7	Н	43.0	-0.7	29.2	73.9

Average Data

Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
2324.808000	33.6	1000.0	1000.000	102.8	Н	134.0	-0.6	20.3	53.9
2351.074667	34.1	1000.0	1000.000	103.7	Н	141.0	-0.7	19.8	53.9
2363.296000	31.8	1000.0	1000.000	101.7	Н	43.0	-0.7	22.1	53.9



2.10.11 Test Results Restricted Band 2310MHz to 2390MHz (Low Channel)



Peak Data

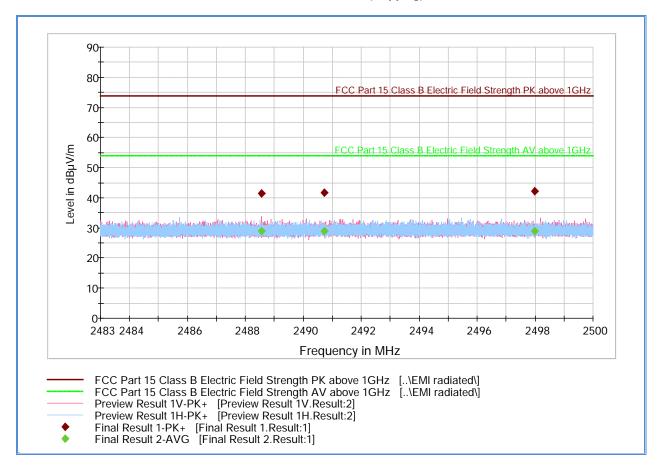
Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
2327.469333	49.2	1000.0	1000.000	116.7	V	223.0	-0.6	24.7	73.9
2341.690667	41.4	1000.0	1000.000	123.7	V	105.0	-0.7	32.5	73.9
2384.602667	58.1	1000.0	1000.000	114.7	V	78.0	-0.6	15.8	73.9

Average Data

Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
2327.469333	28.0	1000.0	1000.000	116.7	V	223.0	-0.6	25.9	53.9
2341.690667	28.3	1000.0	1000.000	123.7	V	105.0	-0.7	25.6	53.9
2384.602667	29.3	1000.0	1000.000	114.7	V	78.0	-0.6	24.6	53.9



2.10.12 Test Results Restricted Band 2483.5MHz to 2500MHz (Hopping)



Peak Data

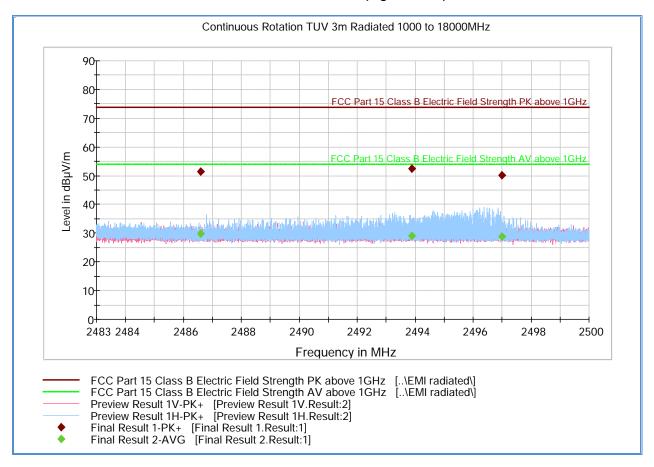
Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
2488.564100	41.4	1000.0	1000.000	137.7	V	219.0	0.0	32.5	73.9
2490.713367	41.6	1000.0	1000.000	300.6	V	89.0	0.0	32.3	73.9
2497.995733	42.3	1000.0	1000.000	102.8	V	1.0	0.0	31.6	73.9

Average Data

Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
2488.564100	28.8	1000.0	1000.000	137.7	V	219.0	0.0	25.1	53.9
2490.713367	28.8	1000.0	1000.000	300.6	V	89.0	0.0	25.1	53.9
2497.995733	28.9	1000.0	1000.000	102.8	V	1.0	0.0	25.0	53.9



$2.10.13 \quad \hbox{Test Results Restricted Band 2483.5MHz to 2500MHz (High Channel)}$



Peak Data

Frequency (MHz)	MaxPeak (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBμV/m)
2486.587033	51.4	1000.0	1000.000	170.6	Н	5.0	0.0	22.5	73.9
2493.888400	52.6	1000.0	1000.000	171.6	Н	4.0	0.0	21.3	73.9
2496.986367	50.1	1000.0	1000.000	115.8	Н	0.0	0.0	23.8	73.9

Average Data

Frequency (MHz)	Average (dBμV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)
2486.587033	29.9	1000.0	1000.000	170.6	Н	5.0	0.0	24.0	53.9
2493.888400	29.1	1000.0	1000.000	171.6	Н	4.0	0.0	24.8	53.9
2496.986367	28.8	1000.0	1000.000	115.8	Н	0.0	0.0	25.1	53.9

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SECTION 3

TEST EQUIPMENT USED



3.1 **TEST EQUIPMENT USED**

List of absolute measuring and other principal items of test equipment.

ID Number (SDGE/SDRB)	Test Equipment	Туре	Serial Number	Manufacturer	Cal Date	Cal Due Date
Antenna Conduc	ted Port Setup					
7604	P-Series Power Meter	N1912A	SG45100273	Agilent	05/27/15	05/27/16
7605	50MHz-18GHz Wideband Power Sensor	N1921A	MY51100054	Agilent	04/10/15	04/10/16
7611	Signal/Spectrum Analyzer	FSW26	102017	Rhode & Schwarz	03/25/15	03/25/16
1003	Signal Generator	SMR-40	1104.0002.40	Rhode & Schwarz	04/29/15	04/29/16
8825	20dB Attenuator	46-20-34	BK5773	Weinschel Corp.	Verified by 10	03 and 7611
Radiated Test Se	tup					
1002	Bilog Antenna	3142C	00058717	ETS-Lindgren	01/30/14	01/30/16
1040	EMI Test Receiver	ESIB40	100292	Rhode & Schwarz	09/29/15	09/29/16
1016	Pre-amplifier	PAM-0202	187	PAM	12/16/15	12/16/16
1051	Double-ridged waveguide horn antenna	3115	9408-4329	EMCO	02/28/14	02/28/16
1049	EMI Test Receiver	ESU	100133	Rhode & Schwarz	03/11/15	03/11/16
8628	Pre-amplifier	QLJ 01182835-JO	8986002	QuinStar Technologies Inc.	03/20/15	03/20/16
1150	Horn antenna	3160-09	012054-004	ETS	07/16/15	07/16/17
1151	Pre-amplifier	TS-PR26	100026	Rhode & Schwarz	05/08/15	05/08/16
1153	High-frequency cable	SucoFlex 100 SX	N/A	Suhner	04/03/15	04/03/16
8543	High-frequency cable	Micropore 19057793	N/A	United Microwave Products	Verified by 10	03 and 7611
6815	2.4GHz Band Notch Filter	BRM50702	008	Micro-Tronics	Verified by 10	03 and 7611
Conducted Emiss	sions					
1024	EMI Test Receiver	ESCS 30	847793/001	Rhode & Schwarz	04/10/15	04/10/16
7567	LISN	FCC-LISN-50-25-2-10	120304	Fischer Custom Comm.	07/14/15	07/14/16
8822	20dB Attenuator	34-20-34	N/A	MCE / Weinschel	02/20/15	02/20/16
8824	20dB Attenuator	34-20-34	N/A	MCE / Weinschel	02/20/15	02/20/16
Miscellaneous						
6792	Multimeter	3478A	2911A70964	Hewlett Packard	08/14/15	08/14/16
11312	Mini Environmental Quality Meter	850027	CF099-56010- 340	Sper Scientific	04/09/15 04/	
	Test Software	EMC32	V8.53	Rhode & Schwarz	N/A	A



3.2 **MEASUREMENT UNCERTAINTY**

For a 95% confidence level, the measurement uncertainties for defined systems are:

3.2.1 Radiated Emission Measurements (Below 1GHz)

	Contribution	Probability Distribution Type	Probability Distribution x _i	Standard Uncertainty u(x _i)	[u(x _i)]²
1	Receiver/Spectrum Analyzer	Rectangular	0.45	0.26	0.07
2	Cables	Rectangular	0.50	0.29	0.08
3	Preamp	Rectangular	0.50	0.29	0.08
4	Antenna	Rectangular	0.75	0.43	0.19
5	Site	Rectangular	3.89	2.25	5.04
6	EUT Setup	Rectangular	1.00	0.58	0.33
			Combined	l Uncertainty (u _c):	2.41
			Co	verage Factor (k):	2
			Expar	nded Uncertainty:	4.82

3.2.2 Radiated Emission Measurements (Above 1GHz)

	Contribution	Probability Distribution Type	Probability Distribution x _i	Standard Uncertainty u(x _i)	[u(x _i)]²
1	Receiver/Spectrum Analyzer	Rectangular	0.57	0.33	0.11
2	Cables	Rectangular	0.70	0.40	0.16
3	Preamp	Rectangular	0.50	0.29	0.08
4	Antenna	Rectangular	0.37	0.21	0.05
5	Site	Rectangular	3.89	2.25	5.04
6	EUT Setup	Rectangular	1.00	0.58	0.33
			Combined	l Uncertainty (uc):	2.40
			Co	verage Factor (k):	2
			Expar	nded Uncertainty:	4.81

3.2.3 Conducted Antenna Port Measurement

	Contribution	Probability Distribution Type	Probability Distribution x _i	Standard Uncertainty u(x _i)	[u(x _i)]²
1	Receiver/Spectrum Analyzer	Rectangular	0.57	0.33	0.11
2	Cables	Rectangular	0.50	0.29	0.08
3	EUT Setup	Rectangular	1.00	0.58	0.33
			Combined	d Uncertainty (uc):	0.72
			Co	verage Factor (k):	2
			Expar	nded Uncertainty:	1.45

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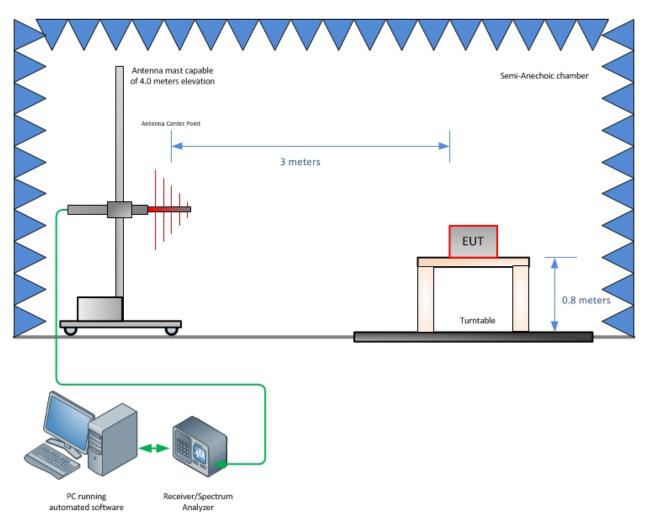


SECTION 4

DIAGRAM OF TEST SETUP

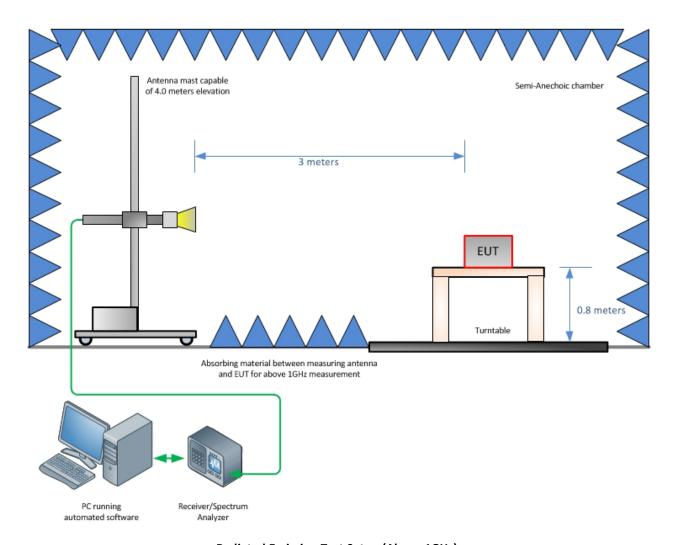


4.1 **TEST SETUP DIAGRAM**



Radiated Emission Test Setup (Below 1GHz)





Radiated Emission Test Setup (Above 1GHz)

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SECTION 5

ACCREDITATION, DISCLAIMERS AND COPYRIGHT



5.1 ACCREDITATION, DISCLAIMERS AND COPYRIGHT

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